

A	Application/Control No.	Applicant(s)/Patent under Reexamination	
1	0/731,946	DAI ET AL.	
E	xaminer	Art Unit	
Δ	Andrew Y. Chou	2192	

	SEAR	CHED	
Class	Subclass	Date	Examiner
	100		
:			· 
,	·		
	· · · · · · · · · · · · · · · · · · ·		

INT	ERFERENC	FERENCE SEARCHED	
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PLUS Search	6/5/2007	AYC		
EASt Text Search	6/5/2007	AYC		
PALM inventor name search	6/3/2007	AYC		
· .				